

Search Notes

Application/Control No.

10/609,499

Examiner

Nathan W. Ha

Applicant(s)/Patent under
Reexamination

LEE ET AL.

Art Unit

2814

SEARCHED

Class	Subclass	Date	Examiner
updated		11/27/05	ng

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR